


<b>Search Notes</b>  	<b>Application/Control No.</b>  10524257	<b>Applicant(s)/Patent Under Reexamination</b>  RENEAU, DANIEL LEE
	<b>Examiner</b>  Tran, Thuy V	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
315	382, 382.1	4/25/07	TT
348	377, 380	4/25/07	TT

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text Search (text enclosed)	4/25/07	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner